

Analytical Evaluation of the MoM Matrix Elements

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Abstract—Derivation of the closed-form Green's functions has eliminated the computationally expensive evaluation of the Sommerfeld integrals to obtain the Green's functions in the spatial domain. Therefore, using the closed-form Green's functions in conjunction with the method of moments (MoM) has improved the computational efficiency of the technique significantly. Further improvement can be achieved on the calculation of the matrix elements involved in the MoM, usually double integrals for planar geometries, by eliminating the numerical integration. The contribution of this paper is to present the analytical evaluation of the matrix elements when the closed-form Green's functions are used, and to demonstrate the amount of improvement in computation time.

I. INTRODUCTION

LECTROMAGNETIC modeling plays an important role in the analysis and the design of electronic packages, high-speed digital circuits, and microwave integrated circuits, most of which are fabricated in a planar environment. Therefore, a variety of numerical techniques for accurately modeling and simulating the electrical performances of such circuits have been proposed and studied extensively. These include the method of moments (MoM) [1], the finite element method (FEM) [2], the finite-difference time-domain method (FDTD) [3], and quasi-static methods like conformal mapping [4]. Among these approaches, the MoM in the spatial and the spectral domains are the most commonly used numerical techniques in the rigorous analysis of printed geometries in multilayer planar media. As these structures are generally used in the design of monolithic microwave integrated circuits (MMIC) and printed antennas, improving the numerical efficiency of the MoM has been a major research topic in computational electromagnetics. In the analysis of electrically small geometries (spanning a few wavelengths in two dimensions), the efficiency can be improved by reducing the computation time used to evaluate the matrix elements, since the significant part of the overall solution time is the calculation of the matrix elements, also called matrix-fill time.

Manuscript received November 10, 1994; revised December 18, 1995. This work was supported in part by NATO's Scientific Affairs Division in the framework of the Science for Stability Programme, and by TUBITAK (The Scientific and Technical Research Council of Turkey) within the scope of COST 245 (European Cooperation in the Field of Scientific and Technical Research) project.

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Publisher Item Identifier S 0018-9480(96)02347-2.

In the spectral domain formulation, the MoM matrix elements involve two-dimensional (2-D) integrals of complex, oscillatory, and slow-converging functions over an infinite domain [5]. Therefore, the numerical evaluation of these elements is quite time consuming, rendering the technique computationally inefficient. Although acceleration techniques and approximations can improve the computational efficiency of the spectral-domain MoM, they are more likely to impose some restrictions.

On the other hand, the application of the spatial-domain MoM to the mixed-potential integral equation (MPIE) requires the necessary Green's functions in the spatial domain [6]. The spatial-domain Green's functions can be obtained from their spectral domain counterparts, which can be derived analytically for planar multilayer media, via Hankel transformation, also called Sommerfeld integral [7], [8]. Because the kernel of the transformation is the Bessel function of the first kind and because the function to be transformed is the spectral-domain Green's function, the integrand is an oscillatory and slow-converging function. Therefore, the calculation of the spatial-domain Green's function, i.e., numerical implementation of the Hankel transformation, is the computational bottleneck of the spatial-domain MoM.

An approach has recently been proposed to accelerate the calculation of the spatial-domain Green's functions [9]. In its original form, the spectral-domain Green's function to be transformed is approximated by complex exponentials via the original Prony method, and the Hankel transformation can be performed analytically with the use of the Sommerfeld identity. Although the original approach was restricted for a single, thick substrate and for an horizontal electric dipole source, it was improved first to cover geometries with a substrate and a superstrate of arbitrary thicknesses [10], then to cover for multilayer geometries with arbitrary thicknesses and for arbitrary source types, horizontal electric dipole (HED), vertical electric dipole (VED), horizontal magnetic dipole (HMD), and vertical magnetic dipole (VMD) [11]. A deficiency of this approach is its being not robust, that is, one needs to examine the function to be approximated prior to the application of an exponential approximation method in order to decide on the approximation parameters, like the range of the approximation and the number of samples in this range. With a recent improvement on the approximation scheme, the calculation of the spatial-domain Green's functions has become robust and extremely efficient [12]. The use of the closed-form Green's functions in conjunction with the MoM results in 2-D integrals over finite domains, and consequently the computational efficiency of the spatial-domain MoM has

been improved significantly, about two order of magnitudes [13], compared to the spectral domain approach. In this paper, we demonstrate that the use of the complex exponentials in place of the spatial-domain Green's functions facilitates analytical evaluation of the double integrals. Therefore, a substantial improvement in the matrix-fill time is achieved.

Since the use of the closed-form Green's functions is crucial for the formulation proposed in this paper, we review closed-form Green's functions in Section II. Section III gives the evaluation of the double integrals and necessary integral identities. Section IV describes application of the formulation to a microstrip geometry and computational efficiency. Section V presents the conclusion.

II. CLOSED-FORM GREEN'S FUNCTIONS

It is well known that the spectral-domain Green's functions for the vector and scalar potentials are represented analytically in a multilayer medium, [11], [14]. Hence, the spatial-domain Green's functions are simply the Hankel transform of the spectral-domain Green's functions as defined

$$G = \frac{1}{4\pi} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \tilde{G}(k_\rho) \quad (1)$$

where $k_\rho^2 = k_x^2 + k_y^2$, ρ is the variable in cylindrical coordinate system, G and \tilde{G} are the Green's functions in the spatial and spectral domains, respectively, $H_o^{(2)}$ is the Hankel function of the second kind and SIP is the Sommerfeld integration path. Note that this integral, also called the Sommerfeld integral, can not be evaluated analytically for the spectral-domain Green's functions \tilde{G} . Chow *et al.* [9] recognized that if the spectral-domain Green's function \tilde{G} is approximated by exponentials, the Sommerfeld integral (1) can be evaluated analytically using the well-known Sommerfeld identity

$$\frac{e^{-jk_s r}}{r} = -\frac{j}{2} \int_{SIP} dk_\rho k_\rho H_o^{(2)}(k_\rho \rho) \frac{e^{-jk_s |z|}}{k_z}. \quad (2)$$

The approximation of the spectral-domain Green's functions by complex exponentials is the heart of this technique, and as described in [12] the two-level approximation scheme in conjunction with the generalized pencil of function (GPOF) method, [15], results in a robust and computationally efficient approach, whose details are given in [12]. Following the two-level approach, the spectral-domain Green's function can be written as

$$\tilde{G} \cong \frac{1}{j2k_{zs}} \left[\sum_{n=1}^{N_1} a_{1n} e^{-\alpha_{1n} k_{zs}} + \sum_{n=1}^{N_2} a_{2n} e^{-\alpha_{2n} k_{zs}} \right] \quad (3)$$

where a_{1n} , α_{1n} and a_{2n} , α_{2n} are the coefficients and exponents obtained from the application of the GPOF method in the first and second parts of the two-level approximation, respectively, and the subscript "s" denotes the layer number of the source location. Once this representation of the spectral-domain Green's function is substituted into (1) and the Sommerfeld identity (2) is employed, the spatial-domain Green's function can be cast into a form of

$$G \cong \sum_{n=1}^{N_1} a_{1n} \frac{e^{-jk_s r_{1n}}}{r_{1n}} + \sum_{n=1}^{N_2} a_{2n} \frac{e^{-jk_s r_{2n}}}{r_{2n}} \quad (4)$$

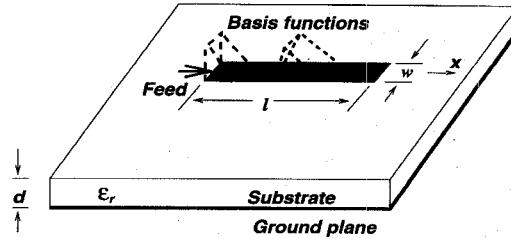


Fig. 1. A typical microstrip geometry. $\epsilon_r = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz.

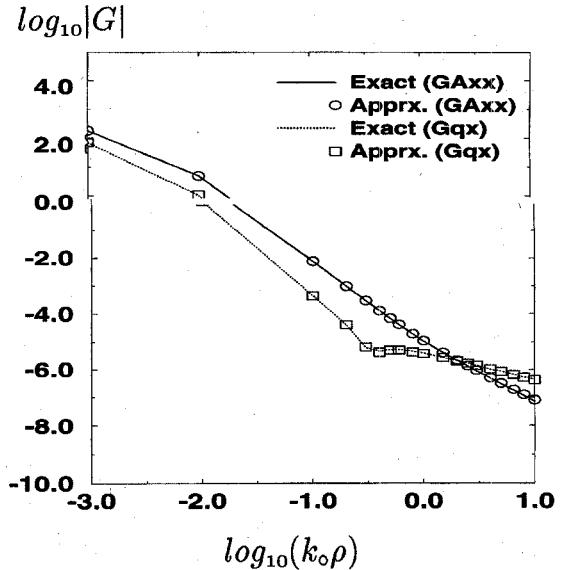


Fig. 2. The magnitude of the normalized Green's functions $4\pi G_{xx}^A/\mu_o$, $4\pi\epsilon_o G_q$. $\epsilon_r = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz.

where $r_{1n} = \sqrt{x^2 + y^2 - \alpha_{1n}^2}$ and $r_{2n} = \sqrt{x^2 + y^2 - \alpha_{2n}^2}$ are the complex distances and k_s is the wave number in the source medium.

As an example, consider the following parameters for the geometry of a substrate backed by a ground plane as in Fig. 1 which shows the dielectric constant of the substrate $\epsilon_r = 4$; the thickness of the substrate $d = 0.02032$ cm; and the frequency of operation $f = 1.0$ GHz. The Green's functions of the vector and scalar potentials due to a HED at the air-substrate interface are obtained in closed forms via two-level approximation scheme, and the coefficients a_{1n} , a_{2n} and the exponents α_{1n} , α_{2n} are given in Table I along with the normalized Green's functions for vector and scalar potentials, $4\pi G_{xx}^A/\mu_o$ and $4\pi\epsilon_o G_q$, respectively, in Fig. 2.

III. FORMULATION

This formulation is applicable to general microstrip geometries in a multilayer medium where it is assumed that the layers extend to infinity in the transverse directions. However, to avoid complexity and to emphasize the main idea of the proposed method, the formulation is presented, without loss of generality, for a microstrip line on a substrate for which only the longitudinal current is assumed to exist.

The mixed-potential integral equation for the microstrip line can be transformed into the matrix equation with the use of

TABLE I
COEFFICIENTS AND EXPONENTS FOR THE CLOSED-FORM GREEN'S FUNCTIONS

$4\pi G_{xx}^A / \mu_0 = \sum_{n=1}^{N_1=4} a_n e^{-jk_s r_n} / r_n$	
a_n	α_n
-1.0000+j0.0000	0.000+j0.0406
0.495e-6-j0.123e-5	-0.0512+j0.0505
0.498e-6+j0.123e-5	0.0511+j0.0506
1.0+j0.0	0.0+j0.0

$4\pi \epsilon_0 G_q = \sum_{n=1}^{N_2=8} a_n e^{-jk_s r_n} / r_n$	
a_n	α_n
-0.590623+j0.0	0.0-j0.103e-3
0.0196+j0.0374	0.0390+j0.0598
-0.4485+j0.0	0.0+j0.0345
0.0196-j0.0374	-0.0390+j0.0598
-0.260e-10+j0.771e-11	-53.33+j439.67
0.279e-5-j0.245e-6	-0.3396+j0.9239
0.204e-6+j0.328e-6	1.0270-j0.2907
1.0+j0.0	0.0+j0.0

the well-known MoM procedure, and a typical matrix element is given below to help demonstrate the use of the formulation

$$\langle T_{xm}, G_{xx}^A * B_{xn} \rangle + \frac{1}{\omega^2} \left\langle T_{xm}, \frac{\partial}{\partial x} \left(G_q * \frac{\partial}{\partial x} B_{xn} \right) \right\rangle \quad (5)$$

where $\langle \cdot, \cdot \rangle$ and $*$ denote inner product and convolution, respectively, and T_{xm}, B_{xn} are the testing and basis functions, respectively. The first inner product of (5) is written explicitly as

$$\begin{aligned} & \langle T_{xm}, G_{xx}^A * B_{xn} \rangle \\ &= \iint_{D_T} dx dy T_{xm}(x, y) \\ & \quad \cdot \iint_{D_B} dx' dy' G_{xx}^A(x - x', y - y') B_{xn}(x', y') \quad (6) \end{aligned}$$

where D_T and D_B denote the domains of the testing and basis functions, respectively, and the closed-form Green's function G_{xx}^A is expressed as in (4). By changing the order of integration, the inner product takes the form of

$$\begin{aligned} & \iint du dv G_{xx}^A(u, v) \iint dx dy T_{xm}(x, y) \\ & \quad \cdot B_{xn}(x - u, y - v) \quad (7) \end{aligned}$$

where the inner double integral is a correlation function represented as $T_{xm} \otimes B_{xn}$. As is well known, the choice of the basis and testing functions are of great importance for the accuracy of the results and for the convergence of the matrix elements involved in the MoM [16]. Since the formulation presented here requires the correlation function to be polynomial function, the choice of testing and basis functions is restricted to polynomial like functions. Therefore, we choose the rooftop functions, which are triangular functions in the longitudinal direction and uniform in the transverse direction, as the basis and testing functions. Half rooftop

functions are also used to model the current density at the load and source terminals [13].

For the above choice of the basis and testing functions, the correlation function becomes

$$T_{xm} \otimes B_{xn} = f(u)g(v) \quad (8)$$

where

$$\begin{aligned} f(u) &= \gamma_3 u^3 + \gamma_2 u^2 + \gamma_1 u + \gamma_0 \\ & (m - n - 2)h_x < u < (m - n + 2)h_x \\ g(v) &= \frac{1}{h_y^2} \begin{cases} v + h_y & -h_y \leq v \leq 0 \\ -v + h_y & 0 \leq v \leq h_y \end{cases} \quad (9) \end{aligned}$$

and $\gamma_0, \gamma_1, \gamma_2, \gamma_3$ are constants determined by m, n , and h_x (the half-span of the basis functions in x -direction); and the length of the unit cell in y -direction, h_y , is chosen to be equal to the width of the microstrip line for the specific geometry considered herein. It should be noted that the formulation given here is also valid for a 2-D patch since the order of the polynomials in (9) is the highest that can be encountered in the analysis. By substituting the correlation function (8) and the Green's function (4) into (7), the inner-product term can be written as

$$\begin{aligned} & \frac{1}{h_y^2} \sum_{n=1}^N a_n \left[\gamma_0 \left(h_y \iint \frac{e^{-jk_s r_n}}{r_n} dv du \right. \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_s r_n}}{r_n} v dv du \right) \right. \\ & \quad + \gamma_1 \left(h_y \iint \frac{e^{-jk_s r_n}}{r_n} u dv du \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_s r_n}}{r_n} uv dv du \right) \right. \\ & \quad + \gamma_2 \left(h_y \iint \frac{e^{-jk_s r_n}}{r_n} u^2 dv du \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_s r_n}}{r_n} u^2 v dv du \right) \right. \\ & \quad + \gamma_3 \left(h_y \iint \frac{e^{-jk_s r_n}}{r_n} u^3 dv du \right. \\ & \quad \left. \left. - \iint \frac{e^{-jk_s r_n}}{r_n} u^3 v dv du \right) \right] \quad (10) \end{aligned}$$

where r_n is either r_{1n} or r_{2n} as defined in (4).

Because the integrals in (10) occur in the calculation of matrix elements, and because they cannot be evaluated analytically, their numerical evaluations constitute almost the entire fill time of the MoM matrix. Although the use of the closed-form Green's functions in conjunction with the MoM improves the matrix fill time significantly [13], it could be further improved if the integrals involved (10) can be evaluated analytically. It has been shown that the Taylor's series expansion of the exponential term in the integrand of the first integral in (10) results in an analytically integrable function over a surface [17]. Using this fact, and some of the integral identities given in [18], we can evaluate the integrals in (10) analytically. The case of the Taylor's series expansion requires examining its convergence for all r_n values

with the same number of terms; therefore, the expansion is performed around different center points R_c for different regions corresponding to different basis and testing function pairs. The m th order Taylor series expansion of $f(z)$ around z_o involves an error term of

$$\text{error} = \left| \frac{f^{m+1}(c)}{(m+1)!} (z - z_o)^{m+1} \right|$$

where c is a point in the region of convergence. As the m th derivative of $e^{-jk_s r_n}$ is bounded by k_s^m , the error introduced by using the m th order expansion is

$$\text{error} \leq \frac{|k_s(r_n - R_c)|^{m+1}}{(m+1)!}.$$

It can be observed that the distance to the center point directly determines the error. Hence, to minimize the error, the locations of the center points are chosen to be the midpoint of the each integration region for which the integration intervals are $2h_y$ and $4h_x$ for v and u integrations, respectively, and consequently, $r_n - R_c \leq \sqrt{(2h_x)^2 + h_y^2}$. For the choice of 20 basis functions for each wavelength, $r_n - R_c$ is bounded by 0.11λ and the error is obtained in the following form

$$\text{error} \leq \frac{(2\pi \times 0.11)^{m+1}}{(m+1)!} = \frac{(0.7)^{m+1}}{(m+1)!} \quad (11)$$

from which it is easily shown that an error bounded by 10^{-4} can be obtained with the use of at least five terms of the Taylor series. The results presented in Section IV demonstrate that the amount of error of 10^{-4} or smaller does not affect the end result as the current distributions obtained by using analytic and numeric integrations are in good agreement. Hence, it is not worthwhile to increase the number of terms any further.

Using the fifth-order Taylor series expansion around R_c , $e^{-jk_s r_n}$ can be approximated as

$$e^{-jk_s r_n} \approx e^{-jk_s R_c} (\beta_0 + \beta_1 r_n + \beta_2 r_n^2 + \beta_3 r_n^3 + \beta_4 r_n^4 + \beta_5 r_n^5) \quad (12)$$

where

$$\begin{aligned} \beta_0 &= \left(1 + jk_s R_c - \frac{k_s^2 R_c^2}{2} - j \frac{k_s^3 R_c^3}{6} + \frac{k_s^4 R_c^4}{24} + j \frac{k_s^5 R_c^5}{120} \right) \\ \beta_1 &= \left(-jk_s + k_s^2 R_c + j \frac{k_s^3 R_c^2}{2} - \frac{k_s^4 R_c^3}{6} - j \frac{k_s^5 R_c^4}{24} \right) \\ \beta_2 &= \left(-\frac{k_s^2}{2} - j \frac{k_s^3 R_c}{2} + \frac{k_s^4 R_c^2}{4} + j \frac{k_s^5 R_c^3}{12} \right) \\ \beta_3 &= \left(j \frac{k_s^3}{6} - \frac{k_s^4 R_c}{6} - j \frac{k_s^5 R_c^2}{12} \right) \\ \beta_4 &= \left(\frac{k_s^4}{24} + j \frac{k_s^5 R_c}{24} \right) \\ \beta_5 &= -j \frac{k_s^5}{120}. \end{aligned}$$

Replacing the exponential term $e^{-jk_s r_n}$ in (10) by its Taylor series expansion given in (12) results in the integrals of the

type

$$\iint r_n^j u^k v^l \, du \, dv \quad \text{for } j = -1, 0, \dots, 4, \quad k = 0, \dots, 3, \\ l = 0, 1. \quad (13)$$

These integrals are analytically integrable and their results are given in the Appendix. Note that the same procedure presented above can be applied to the second inner-product term of (5) in which G_q has the same functional form as G_{xx}^A given in (4).

IV. RESULTS AND DISCUSSIONS

In this part of the study, the formulation described above is applied to a microstrip line to evaluate computational efficiency. The dielectric constant of the medium is $\epsilon_r = 4.0$, the ratio of line width w to substrate thickness d is 4.0. The thickness of the substrate is 0.02032 cm (= 8.0 mils.), the frequency is 1 GHz, and the length of the line is 10 cm. Computational efficiency of the proposed method is assessed in terms of the CPU (central processing unit) time obtained from a SUNsparc-10 workstation.

The current distribution on the microstrip line is obtained by numerically integrating the double integrals (7) (Case 1) involved in the MoM matrix elements, and then by using the analytic integration formulation presented in Section III (Case 2). The current distributions obtained via the use of the numerical integration (Case 1) have been verified by comparing it with the results obtained via the transmission line method described in [13]; therefore, Case 1 serves here as a reference for the accuracy of the current distribution as well. In the numerical integration, 16-point Gauss quadrature integration algorithm, which is considered to be one of the fastest numerical integration algorithms, is employed for the double integrals for which the range of the integration is divided into subregions to guarantee the convergence of the numerical integration. For both cases, the CPU times are obtained for different numbers of basis functions and are listed in Table II. The current distributions obtained via numerical and analytical evaluations of the integrals for 40 basis functions are shown in Fig. 3. It can be observed from Table II that the elimination of the numerical integrals reduces the computation time approximately by a factor of 40. Besides the improvement in computational efficiency, the formulation based on the analytical integration also provides a number of other advantages. First, as the MoM becomes a technique free from any numerical integrations, the numerical errors due to integration and the time used to find an appropriate numerical integration algorithm are eliminated. Second, as the matrix entries are expressed in closed-forms, the effect of changes in geometrical parameters, such as length and width of the microstrip line, onto the output parameters like, current distribution, input impedance or spurious radiation, can be studied analytically by taking a derivative with respect to the desired parameter. Finally, if a method uses numerical integrations, it is necessary to extract the singularity at the source point, while in the analytic integration formulation this problem is completely eliminated because the singularities involved are integrable over a surface. It should be noted that

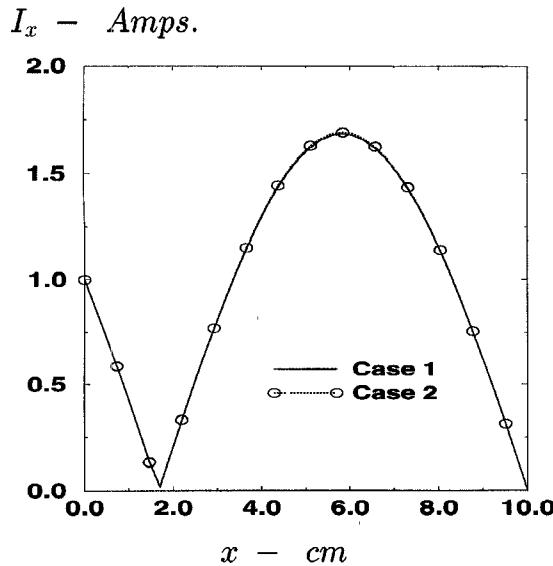


Fig. 3. Current distributions obtained by using 40 basis functions. $\epsilon_r = 4.0$, $d = 0.02032$ cm, $f = 1.0$ GHz, $w = 0.08128$ cm, $l = 10$ cm.

TABLE II
CPU TIMES FOR DIFFERENT NUMBER OF BASIS FUNCTIONS

number of basis func.	CPU time in sec. (Case 1)	CPU time in sec. (Case 2)
10	13.3	0.36
20	27.0	0.65
30	39.0	0.98
40	52.95	1.33

the application of the proposed approach here has no restriction for the size of the geometry, provided the closed-form Green's functions are valid for the distance as far as the maximum distance of the geometry.

V. CONCLUSION

When the spatial-domain MoM is used in conjunction with the closed-form Green's functions for the solution of the mixed-potential integral equation, the MoM matrix elements involve 2-D integrals whose numerical evaluations increase the matrix fill-time. In order to improve the numerical efficiency of the method, the integrand is approximated by its Taylor series and each term of the expansion is integrated analytically. By eliminating the numerical integration from the MoM, the matrix fill-time is decreased drastically, which is a significant improvement in the matrix-fill time of the MoM. This acceleration in the matrix fill time makes the MoM a fast full-wave analysis technique which can be utilized in an optimization algorithm for the solution of a design problem. Besides, the proposed method offers other advantages such as expressing the matrix entries in closed-forms, which opens up the possibility of investigating the effect of some parameters on the end result by examining the matrix entries analytically.

APPENDIX THE ANALYTIC EVALUATION OF THE INTEGRALS GIVEN IN (13)

$$R = \sqrt{u^2 + v^2 + c^2}$$

where c is any of the complex exponents. Some special integrals are defined in order to simplify the formulation

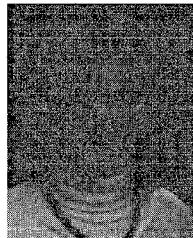
$$\begin{aligned}
 J_0 &= \int R du = \frac{1}{2} (Ru + (v^2 + c^2) \cdot \log(u + R)) \\
 J_1 &= \int u R du = \frac{R^3}{3} \\
 J_2 &= \int u^2 R du \\
 &= \frac{u(v^2 + c^2 + 2u^2)R}{8} - \frac{(v^2 + c^2)^2}{8} \cdot \log(u + R) \\
 J_3 &= \int u^3 R du = \frac{R^5}{5} - (v^2 + c^2) \frac{R^3}{3} \\
 J_4 &= \int u^4 R du \\
 &= \left(-\frac{3}{2}(v^2 + c^2)^2 + (v^2 + c^2)u^2 + 4u^4 \right) \left(\frac{uR}{24} \right) \\
 &\quad + \frac{1}{16}(v^2 + c^2)^3 \log(u + R) \\
 J_5 &= \int u^5 R du = \frac{R^7}{7} - \frac{2}{5}R^5(v^2 + c^2) \\
 &\quad + \frac{R^3}{3}(v^2 + c^2)^2 \\
 J_6 &= \int u^6 R du \\
 &= \frac{7u}{8}J_5 - \frac{(v^2 + c^2)}{40}J_4 \\
 &\quad + \frac{(v^2 + c^2)^2}{30}J_2 - \frac{(v^2 + c^2)^3}{15}J_0 \\
 J_7 &= \int u^7 R du \\
 &= \frac{R^9}{9} - 3(v^2 + c^2) \frac{R^7}{7} \\
 &\quad + 3(v^2 + c^2)^2 \frac{R^5}{5} - (v^2 + c^2)^3 \frac{R^3}{3} \\
 K_0 &= \int \frac{1}{R} du = \log(u + R) \\
 K_1 &= \int \frac{u}{R} du = R \\
 K_n &= \int \frac{u^n}{R} du = J_{n-2} - (v^2 + c^2) \cdot K_{n-2} \\
 I_0 &= \int \frac{1}{(u^2 + c^2)R} du \\
 &= \frac{1}{vc} \arctan\left(\frac{uv}{cR}\right)
 \end{aligned}$$

$$\begin{aligned}
I_1 &= \int \frac{u}{(u^2 + c^2)R} du \\
&= \frac{\log(R-v) - \log(R+v)}{2v} \\
I_n &= \int \frac{u^n}{(u^2 + c^2)R} du \\
&= K_{n-2} - c^2 I_{n-2} \\
L_0 &= \int \frac{1}{(u^2 + c^2)} du \\
&= \frac{1}{c} \arctan\left(\frac{u}{c}\right) \\
L_1 &= \int \frac{u}{(u^2 + c^2)} du = \frac{\log(u^2 + c^2)}{2} \\
L_n &= \int \frac{u^n}{(u^2 + c^2)} du = \frac{u^{n-1}}{n-1} - c^2 L_{n-2} \\
M_n &= \iint \frac{u^n}{R} dv du \\
&= (u^{n+1} \log(v+R) - L_{n+2} \\
&\quad + v I_{n+2})/(n+1) \\
\iint u^n R dv du &= \frac{1}{2}(v J_n + M_{n+2} + c^2 M_n) \\
\iint u^n R^2 dv du &= \frac{u^{n+1}}{n+1} \left(\frac{v^3}{3} + v c^2 \right) + \frac{u^{n+3}}{n+3} v \\
\iint u^n R^3 dv du &= \frac{5}{8} v J_{n+2} + \frac{v}{4} \left(\frac{5c^2}{2} + v^2 \right) J_n \\
&\quad + \frac{3}{8} (M_{n+4} + 2c^2 M_{n+2} + c^4 M_n) \\
\iint u^n R^4 dv du &= \frac{u^{n+1}}{n+1} \left(c^4 v + \frac{v^5}{5} + \frac{2c^2 v^3}{3} \right) \\
&\quad + \frac{2u^{n+3}}{n+3} \left(\frac{v^3}{3} + c^2 v \right) + \frac{v u^{n+5}}{n+5} \\
\iint \frac{u^n v}{R} dv du &= J_n \\
\iint u^n v R dv du &= \frac{J_{n+2}}{3} + \frac{(v^2 + c^2) J_n}{3} \\
\iint u^n v R^2 dv du &= \frac{u^{n+3} v^2}{2(n+3)} + \frac{v^2}{2} \left(c^2 + \frac{v^2}{2} \right) \frac{u^{n+1}}{n+1} \\
\iint u^n v R^3 dv du &= \frac{J_{n+4}}{5} + \frac{2(v^2 + c^2)}{5} J_{n+2} \\
&\quad + \frac{(v^2 + c^2)^2}{5} J_n \\
\iint u^n v R^4 dv du &= \frac{u^{n+5} v^2}{2(n+5)} + \frac{u^{n+3}}{n+3} \left(c^2 v^2 + \frac{v^4}{2} \right) \\
&\quad + \frac{u^{n+1}}{n+1} \left(\frac{c^4 v^2}{2} + \frac{v^6}{6} + \frac{c^2 v^4}{2} \right).
\end{aligned}$$

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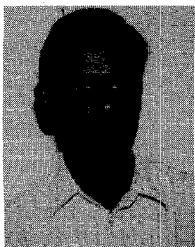


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